



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/072,335	TANAKA ET AL.	
	Examiner	Art Unit	
	Shi K. Li	2633	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
398	185			398	186	188				
INTERNATIONAL CLASSIFICATION										
H	0	4	B							
				10104						
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Shi K. Li 9/26/2005 (Assistant Examiner) (Date)	 JASON CHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600	Total Claims Allowed: 9	
Sharon West 10/12/05 (Legal Instruments Examiner) (Date)		O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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